

Agilent Technologies

E5900B Emulation Probes

Data Sheet

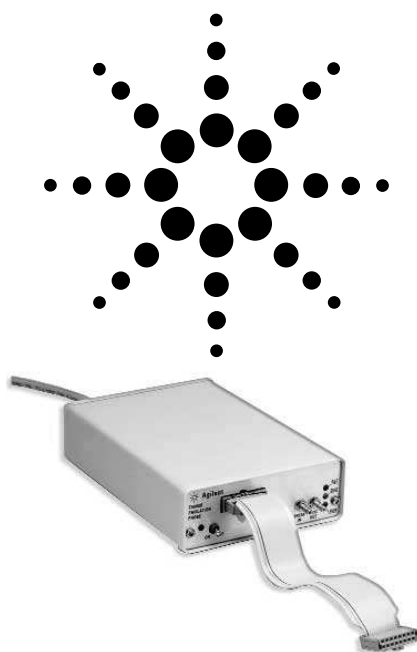


Figure 1. Agilent E5900B emulation probe

The Agilent E5900B series of emulation probes provide an electrical interface to a supported microprocessor's on-chip debug port (BDM or JTAG), enabling access for either debuggers or Agilent 16700 Series logic analyzers and oscilloscopes.

Agilent E5900B emulation probes connect to industry-leading debuggers via 10/100 Base-T LAN. While operating with the debugger, the probes provide code downloading as well as run control and access to on-chip registers and memory.

The emulation probes are self-powered, making them ideally suited for working in battery-powered and other systems that have not budgeted extra power for debug tools.

Debugger Interface

Agilent engineering labs have tested the compatibility of the E5900B probes with industry-leading debuggers and development systems from Green Hills, Mentor Graphics, Metrowerks and Wind River for a wide range of processors. Please refer to the Agilent web site for the most current listing of debuggers at www.agilent.com

- Support for ARM7/ARM9/ARM9TDMI, MIPS, Motorola/IBM PowerPC 4xx, 6xx, & 8xx; MPC 82xx; MPC 74xx and M-Core processors
- 10/100T LAN connectivity to industry-standard debuggers
- Download speeds up to 1Mbyte/sec
- Standalone operation with an industry-leading debugger

- Operation coupled with logic analyzers and oscilloscopes in the Agilent 16700 Series logic analysis systems for complete target system analysis
- Support for 1.2 V to 5 V operation
- IEEE 1149.1 (JTAG) or BDM connection to the processor's debug port
- Self powered, no target power required
- Easy upgrade to meet changing processor needs

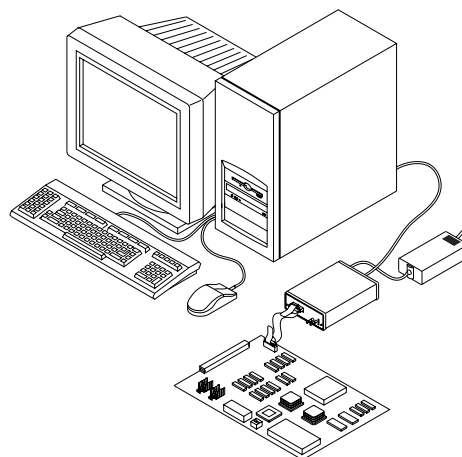


Figure 2. Agilent E5900B operating with a PC hosted debugger via LAN connection

A System Troubleshooting Tool

Coupling an oscilloscope and/or logic analyzer to an emulation probe via the probe's trigger output and break input ports lets you view system operation as related to CPU status. For example, in systems where the processor supports an external break input, an oscilloscope's trigger output can command the processor to break if a critical control line ever enters a specified state.

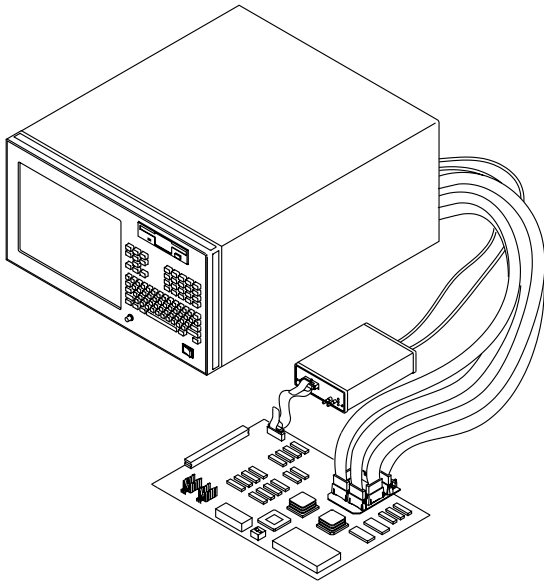


Figure 3. Agilent E5900B emulation module operating with the 16702 logic analyzer

Quickly Isolate System Integration Problems

The Agilent E5900B emulation probes can be tightly coupled to the Agilent 16700 Series logic analysis systems. These systems enable quick determination of your most difficult hardware, software and system integration problems. The E5900B operate under control of the logic analyzer via the LAN or with the addition of the E5901B emulation module. With logic analysis providing timing and state analysis of system operation, the emulation probe can monitor internal microprocessor activity. This combination of logic analysis and emulation gives you a view of your total system, encompassing everything from signals to source code.

Easy Migration Protects Your Investment

The E5900B emulation probes can continue to be useful development tools when a different processor is selected for new projects. Agilent migration kits provide an easy and economical method to convert existing emulation probes to keep up with your changing processor needs.

Selection Guide

Select the configuration of the emulation probe for your application from the following table.

Processor	Agilent E5900B Option #
Arm ARM7/9 TDMI ARM7/9	300
IBM PPC 4xx PPC 6xx PPC7xx	060 060 070
MIPS MIPS 32 4Kc MIPS 32 4Km MIPS 32 4Kp MIPS 64 5Kc	200
Motorola MPC 6xx MPC 7xx MPC 8xx MPC 74xx MPC 82xx M-CORE	060 070 080 110 100 090

Performance Characteristics

Probe Input/Output Characteristics

Target connection	JTAG as per IEEE 1149.1 specification. Pin out is specific to the processor. Details of the JTAG connection pin out can be found on the Agilent web at http://www.agilent.com
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JTAG Input Characteristics

TDO, DBGACK, & RTCK	$R_{in} = 4.7k \Omega$ pull-up to V_{ref} C_{in} TDO = 75 pF, DBGACK = 95 pF, DTCK = 80 pF
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TDO sampling with respect to TCK	Selectable: falling or rising TCK Minimum required setup & hold window = 7.0 ns $t_{su} = 7.5$ ns, $t_h = -0.5$ ns
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V_{ref}^1	$R_{in} = 25k \Omega$ pull down to ground
SRST ²	R_{in} (inactive) = 4.7k Ω pull-up to V_{ref} R_{in} (active) = 12 Ω pull down to ground $C_{out} = 200$ pF

JTAG Output Characteristics

TDI, TCK, TMS, TRST, & DBGRQ	$V_{oh}/I_{oh} = 66 \pm 15 \Omega$ to V_{ref} $V_{ol}/I_{ol} = 66 \pm 15 \Omega$ to 0.2V
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Delay	TDI & TMS delay from TCK falling edge to TDI and TMS valid Min 1 ns max 2.5 ns
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Operating Voltage

Operating range	1.2 V to 5.0 V
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Communications

LAN	RJ-45 connector IEEE 802.3 Auto sensing 10/100 BASE-T Ethernet maximum download speed 1 Mbyte/sec
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Trigger out	SMB (m) 2 V into 50 ohm load
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Break in	SMB (m) Input RC = 2k ohms & 20 pF Edge triggered, TTL level Maximum input = 5V above VCC
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Power

Power supply	12 V dc, maximum current = 1 A External module, 100–240 V input auto sensing 50/60 Hz, IEC 320 connector
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Physical size	105 mm (4.13 inch) wide x 151 mm (5.94 inch) deep x 40 mm (1.57 inch) high
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Environmental

Temperature	Operating: 0°C to +40°C (+32°F to +104°F) Not operating: -40°C to +60°C (-40°F to +140°F)
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Altitude	Operating and not operating: 4600 m (15 K feet)
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Relative humidity	80% @ 40°C for 24 hours
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Regularity Compliance

EMC CISPR 11:1990/EN 55011:1991 Group 1, Class A IEC 801-2:1991/EN50082-1:1992 4kVCD,8kV AD IEC 801-3:1994/EN 50082:1993 3 V/m (1 kHz 80% AM,27-1 kHz) IEC 801-4:1998/EN 50082-1:1992 0.RkV Sig lines, 1 kV power lines

Safety Approval

IEC 1010-1:1990; AMD 1:1992; UL 1244; CSA-C22.2 No. 231
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- V_{ref} is used to determine the target power status and the reference for input threshold and output voltage swings. The Agilent emulation probes do not draw power from the target system.
- Open collector output. Pulled up to generated voltage equivalent to the V_{ref} voltage with a 2.61 k Ω pull-up resistor.

E5900B Emulation Probe Options	
Option Number	Processors Supported
060	PPC 4xx, PPC 6xx, & MPC 6xx
070	MPC 7xx
080	MPC 8xx
090	M•Core
100	MPC 82xx
110	MPC 7400, MPC 7410, MPC7440 and MPC 7450
200	MIPS 32 MIPS 64
300	ARM7, ARM 9, & ARM 9 TDMI
<p>Note: Most current supported processor information can be obtained from the Agilent web at www.cos.agilent.com/probe</p>	

Ordering Information

E5900B Emulation Probe

Emulation probe that provides access to the processor via BDM or JTAG interface.

Supplied with power supply, line cord, User's Guide, and processor specific interface cables.

E5901B Emulation Module

Emulation probe and interface module for Agilent 16700 Series logic analyzer.

Supplied with E5900B emulation probe, emulation interface module, power supply, line cord, logic analyzer application software, and processor specific interface cables.

E5902B Migration Kit

Personality conversion of an existing E5900B emulation probe or E5901B emulation module to support a different processor.

Supplied with software to reprogram the E5900B, User's Guide, tool kit, and processor specific interface cables.

Recommended Accessories

8120-5048 SMB (f) to BNC (m)

50 Ω trigger cable 1.22 m (48 inch)

Related Literature

Document Number

Agilent Technologies 16700 Series

Logic Analysis System, Product Overview5968-9661E

Processor and Bus Support for

Agilent Technologies Logic Analyzers, Configuration Guide5966-4365E

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Korea:

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(fax) (305) 269 7599

Taiwan:

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Other Asia Pacific Countries:

(tel) (65) 6375 8100
(fax) (65) 6836 0252
Email: tm_asia@agilent.com

Online Assistance:

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